

MOSFET – Power, Single N-Channel

40 V, 342 A, 0.81 m Ω

NTMJS0D9N04C

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- LFPAK8 Package, Industry Standard
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Symbol | Parameter | | | Value | Unit | |
|-----------------------------------|--|-----------------|----------------------------|----------------|------|--|
| V _{DSS} | Drain-to-Source Voltage | | | 40 | V | |
| V _{GS} | Gate-to-Source Voltage | | | 20 | V | |
| I _D | Continuous Drain Cur- | Steady State | T _C = 25°C | 342 | Α | |
| | rent $R_{\theta JC}$ (Notes 1, 3) | State | T _C = 100°C | 242 | | |
| P _D | Power Dissipation $R_{\theta JC}$ (Note 1) | | T _C = 25°C | 180 | W | |
| | | | T _C = 100°C | 90 | | |
| I _D | Continuous Drain | Steady | T _A = 25°C | 52 | Α | |
| | Current $R_{\theta JA}$ State (Notes 1, 2, 3) | | T _A = 100°C | 37 | | |
| P _D | Power Dissipation R _{0JA} (Notes 1, 2) | | T _A = 25°C | 4.2 | W | |
| | | | T _A = 100°C | 2.1 | | |
| I _{DM} | Pulsed Drain Current | $T_A = 25$ | °C, t _p = 10 μs | 900 | Α | |
| T _J , T _{stg} | Operating Junction and Storage Temperature Range | | | -55 to +175 | °C | |
| I _S | Source Current (Body Diode) | | | 150 | Α | |
| E _{AS} | Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 33 A) | | | 1945 | mJ | |
| TL | Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | 260 | °C | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

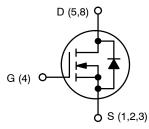
| Symbol | Parameter | Value | Unit |
|-----------------|---|-------|------|
| $R_{\theta JC}$ | Junction-to-Case - Steady State | 0.83 | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient - Steady State (Note 2) | 35.9 | |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX | | |
|----------------------|-------------------------|--------------------|--|--|
| 40 V | 0.81 mΩ @ 10 V | 342 A | | |

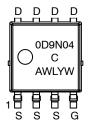


LFPAK8 CASE 760AA



N-CHANNEL MOSFET

MARKING DIAGRAM



0D9N04C = Specific Device Code A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Symbol | Parameter | Test Cond | Test Condition | | Тур | Max | Unit |
|--|--|---|---|--|------|------|-------|
| OFF CHAR | ACTERISTICS | | | | | | • |
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | V _{GS} = 0 V, I _D | $V_{GS} = 0 \text{ V}, I_D = 250 \mu A$ | | | | V |
| V _{(BR)DSS} / T _J | Drain-to-Source Breakdown Voltage Temperature Coefficient | | | | 14 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{GS} = 0 V, | T _J = 25 °C | | | 10 | μΑ |
| | | V _{DS} = 40 V | T _J = 125°C | | | 250 | |
| I _{GSS} | Gate-to-Source Leakage Current | $V_{DS} = 0 V, V_{G}$ | _S = 20 V | | | 100 | nA |
| ON CHARA | CTERISTICS (Note 6) | | | | | | |
| V _{GS(TH)} | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_{D}$ | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | | | 4.0 | V |
| V _{GS(TH)} /T _J | Threshold Temperature Coefficient | | | | 7.4 | | mV/°C |
| R _{DS(on)} | Drain-to-Source On Resistance | V _{GS} = 10 V | I _D = 50 A | | 0.68 | 0.81 | mΩ |
| 9FS | Forward Transconductance | V _{DS} =15 V, I | V _{DS} =15 V, I _D = 50 A | | 400 | | S |
| CHARGES, | CAPACITANCES & GATE RESISTANCE | | | | | | |
| C _{ISS} | Input Capacitance | V _{GS} = 0 V, f = 1 MH | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 20 V | | 7400 | | pF |
| C _{OSS} | Output Capacitance | | | | 4600 | | |
| C _{RSS} | Reverse Transfer Capacitance | | | | 127 | | |
| Q _{G(TOT)} | Total Gate Charge | V _{GS} = 10 V, V _{DS} = | V _{GS} = 10 V, V _{DS} = 32 V; I _D = 50 A | | 117 | | nC |
| Q _{G(TH)} | Threshold Gate Charge | V _{GS} = 10 V, V _{DS} = | V _{GS} = 10 V, V _{DS} = 32 V; I _D = 50 A | | 18 | | 1 |
| Q _{GS} | Gate-to-Source Charge | | | | 29 | | 1 |
| Q _{GD} | Gate-to-Drain Charge | | | | 28 | | 1 |
| V _{GP} | Plateau Voltage | | 7 | | | | V |
| SWITCHING | G CHARACTERISTICS (Note 7) | | | | | | • |
| t _{d(ON)} | Turn-On Delay Time | V _{GS} = 10 V, V _E | _{OS} = 32 V, | | 20 | | ns |
| t _r | Rise Time | $I_D = 50 \text{ A}, R_G$ | I_D = 50 A, R_G = 2.5 Ω | | 14 | | 1 |
| t _{d(OFF)} | Turn-Off Delay Time | | | | 71 | | 1 |
| t _f | Fall Time | | 7 | | | | 1 |
| DRAIN-SO | URCE DIODE CHARACTERISTICS | • | | | | | • |
| V_{SD} | Forward Diode Voltage | V _{GS} = 0 V, | T _J = 25°C | | 0.8 | 1.2 | V |
| | | I _S = 50 A | T _J = 125°C | | 0.6 | | 1 |
| t _{RR} | Reverse Recovery Time | | V _{GS} = 0 V, dlS/dt = 100 A/μs, I _S = 50 A | | 82 | | ns |
| t _a | Charge Time | I _S = 50 | | | 54 | | 1 |
| t _b | Discharge Time | 7 | | | 28 | | 1 |
| Q _{RR} | Reverse Recovery Charge | | - | | 148 | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

5. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{6.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

^{7.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

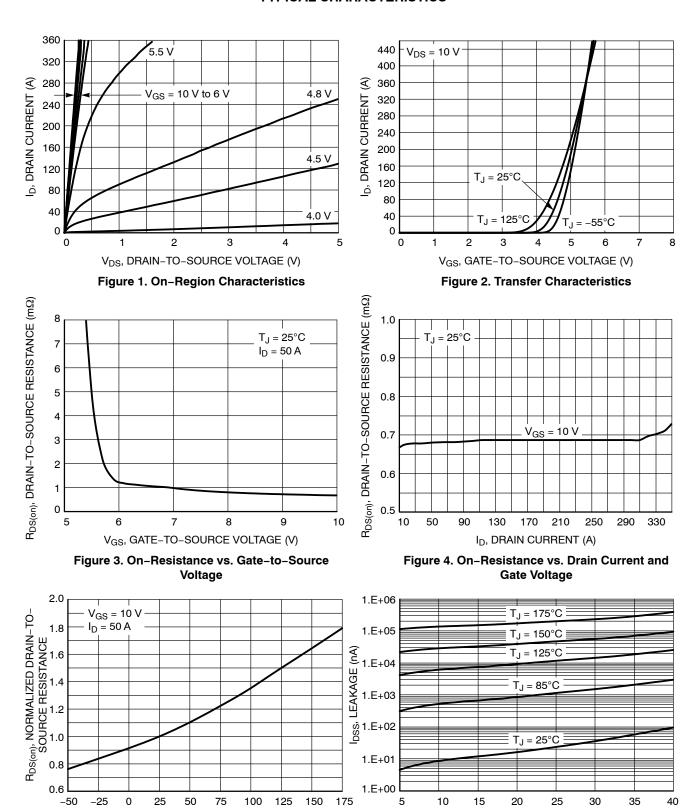


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

TYPICAL CHARACTERISTICS (continued)

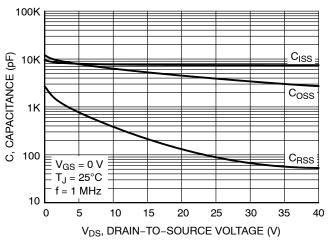


Figure 7. Capacitance Variation

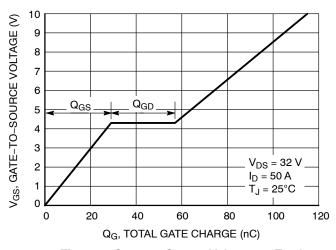


Figure 8. Gate-to-Source Voltage vs. Total Charge

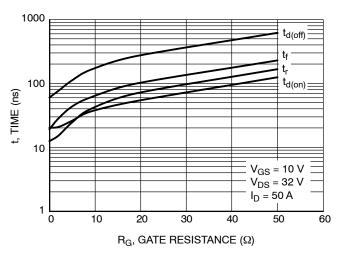


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

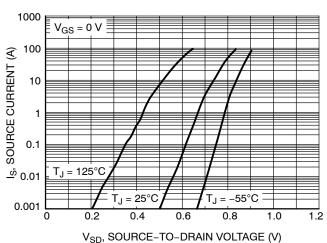


Figure 10. Diode Forward Voltage vs. Current

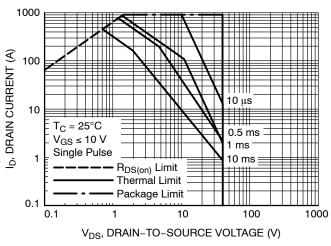


Figure 11. Maximum Rated Forward Biased Safe Operating Area

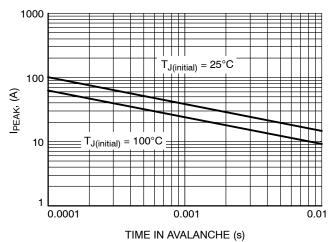


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS (continued)

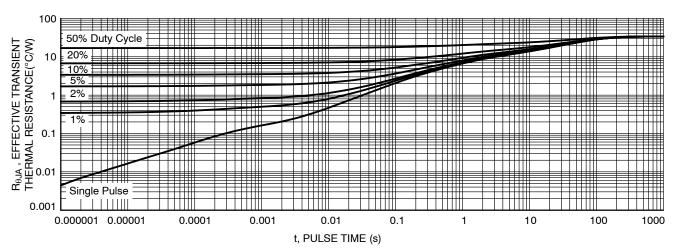


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|-----------------|---------|---------------------|-----------------------|
| NTMJS0D9N04CTWG | 0D9N04C | LFPAK8 (Pb-Free) | 3,000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





LFPAK8 4.90x4.80x1.12MM, **1.27P**CASE 760AA ISSUE D

DATE 22 APR 2024





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. OPTIONAL MOLD FEATURE.









RECOMMENDED LAND PAD

*FOR ADDITIONAL INFORMATION ON OUR

MANUAL, SOLDERRM/D.

PB-FREE STRATEGY AND SOLDERING DETAILS.

PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE

MILLIMETERS MIN NOM DIM 1.10 1.20 1.30 Α A1 0.00 0.08 0.15 A2 1.10 1.15 1.20 АЗ 0.25 BSC b 0.40 0.45 0.50 0.45 0.55 0.65 b4 0.19 0.22 0.25 С c2 0.19 0.22 0.25 4.70 4.80 4.90 D D1 3.80 4.00 4.20 2.98 D2 3.08 3.18 D3 0.30 0.40 0.50 D4 0.55 0.65 0.75 4.80 4.90 5.00 Ε E1 5.05 5.15 5.25 E2 3.91 3.96 4.01 1.27 BSC е 0.635 BSC e/2 Н 6.00 6.15 6.30 L 0.50 0.70 0.90 0.25 0.35 L1 0.15 L2 1.10 REF 4° θ

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Work Week

A = Assembly Location

WL = Wafer Lot Y = Year

W

*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:

98AON82475G

Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.

DESCRIPTION:

LFPAK8 4.90x4.80x1.12MM, 1.27P

PAGE 1 OF 1

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales